

**Search Notes**

Application/Control No.

10/715,686

Examiner

Cheukfan Lee

Applicant(s)/Patent under  
Reexamination

ONISHI ET AL.

Art Unit

2625

**SEARCHED**

Class	Subclass	Date	Examiner
358	484,475	12/31/2007	C.L.
	483,482		
	512-514		
	474,497		
	509,505		
	487,506		
250	208.1,216		
	239		
	234-236		
362	558,555		
	551,582		
385	147,146		
355	67,68		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
358	475,483	12/31/2007	C.L.
	484		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search: see result	12/31/2007	C.L.
Inventor search		